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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Breitwisch et al.

U.S. Patent No. 6,778,449 *B2*

→ Serial No. 10/064,302

Issued: August 17, 2004

Filed: July 1, 2002

For: METHOD AND DESIGN FOR MEASURING SRAM ARRAY LEAKAGE
MACRO (ALM)

Certificate
SEP 01 2004
of Correction

Commission for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

SUBMISSION OF CERTIFICATE OF CORRECTION

Sir:

Attached herewith are duplicate copies of a Certificate of Correction in connection with the above-identified patent to correct errors in the drawings. It is requested that the Patent Office substitute Figs. 1-5 of the drawings with the attached formal drawings of Figs. 1-5. Please send the certified copy of the Certificate of Correction to the undersigned attorney.

Please charge any deficiencies and credit any overpayments to Attorney's Deposit Account Number 09-0456.

Respectfully submitted,

Dated: 8/20/04

Frederick W. Gibb, III
Reg. No. 37,629

McGinn & Gibb, P.L.L.C.
2568-A Riva Road
Suite 304
Annapolis, MD 21401
(301) 261-8071
Customer Number: 29154

SEP 02 2004

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

REGISTRATION NO. :	6,778,449 B2
DATED :	August 17, 2004
INVENTOR(S) :	Breitwisch et al.

It is certified that error appears in the above-identified patent and that said Letters Patent are hereby corrected as shown below:

Please substitute Figs. 1-5 with the attached formal drawings of Figs. 1-5.

MAILING ADDRESS OF SENDER:

Frederick W. Gibb, III
McGinn & Gibb, PLLC
2568-A Riva Road
Suite 304
Annapolis, MD 21401

PATENT NO. 6,778,449 B2

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McGinn & Gibb, PLLC
2568-A Riva Road
Suite 304
Annapolis, MD 21401

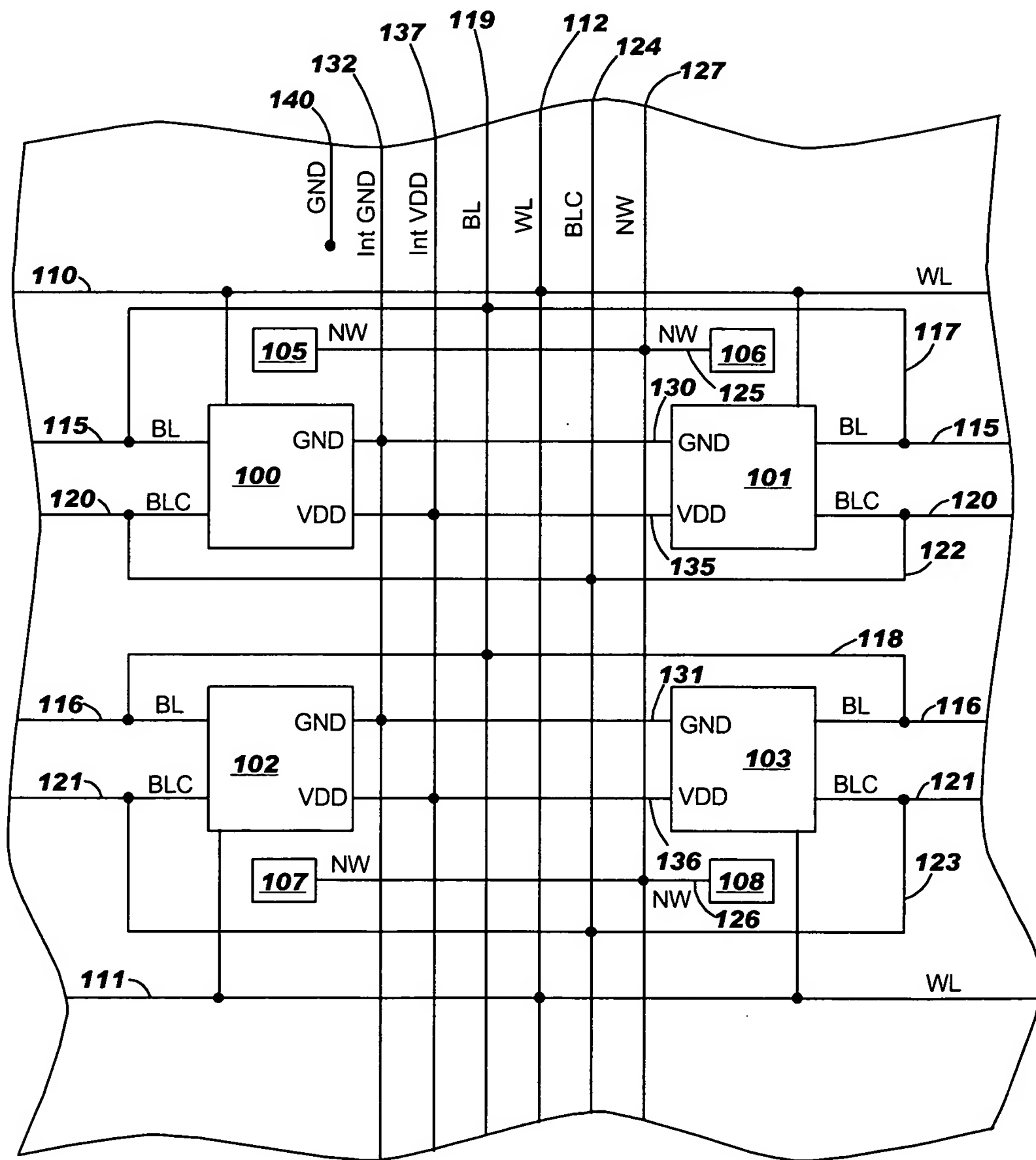
PATENT NO. 6,778,449 B2

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FIG. 1





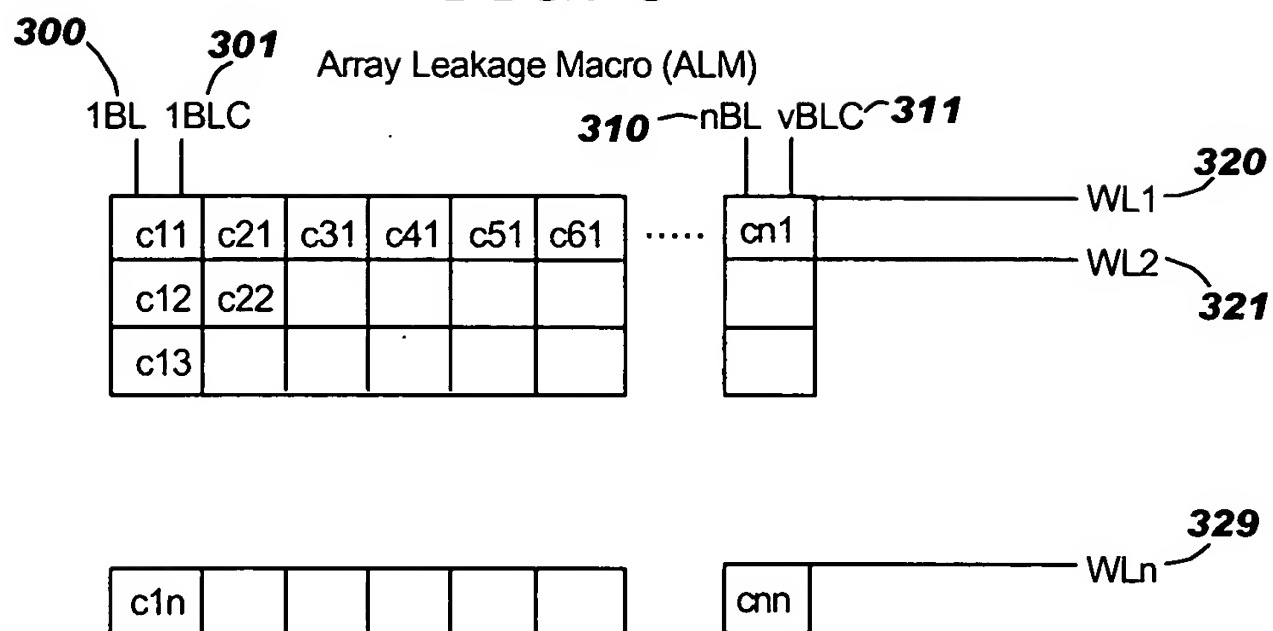
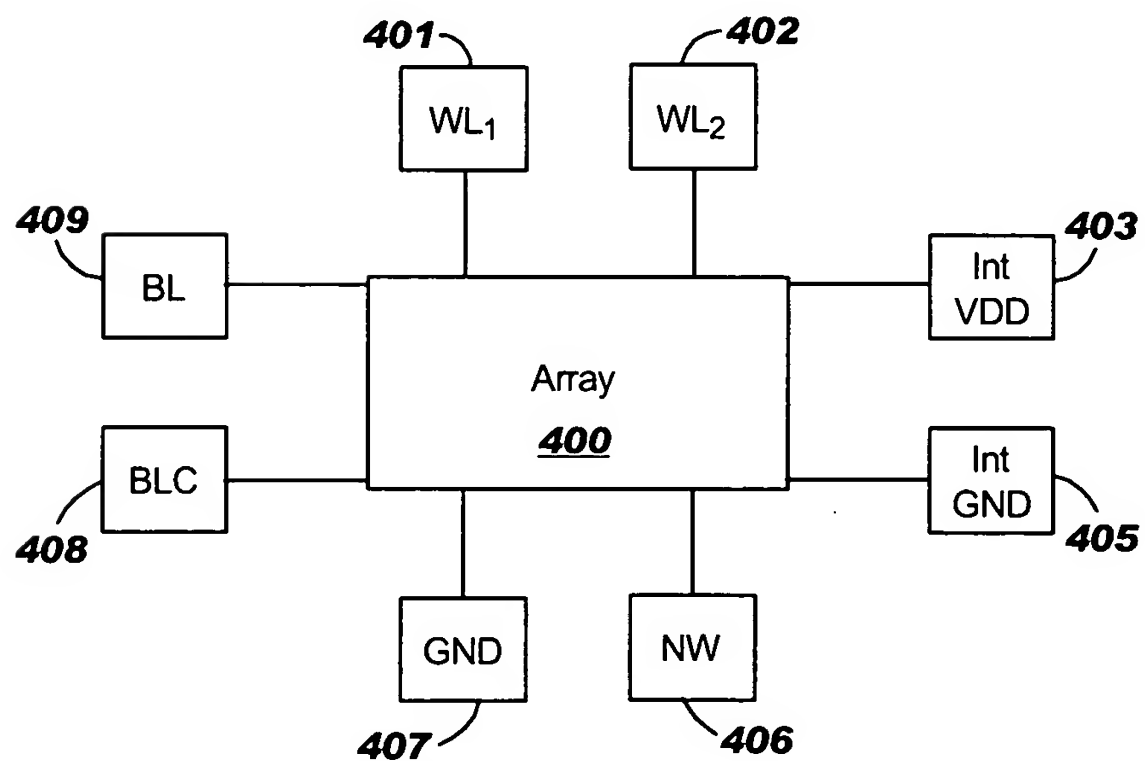
3/4
FIG. 3

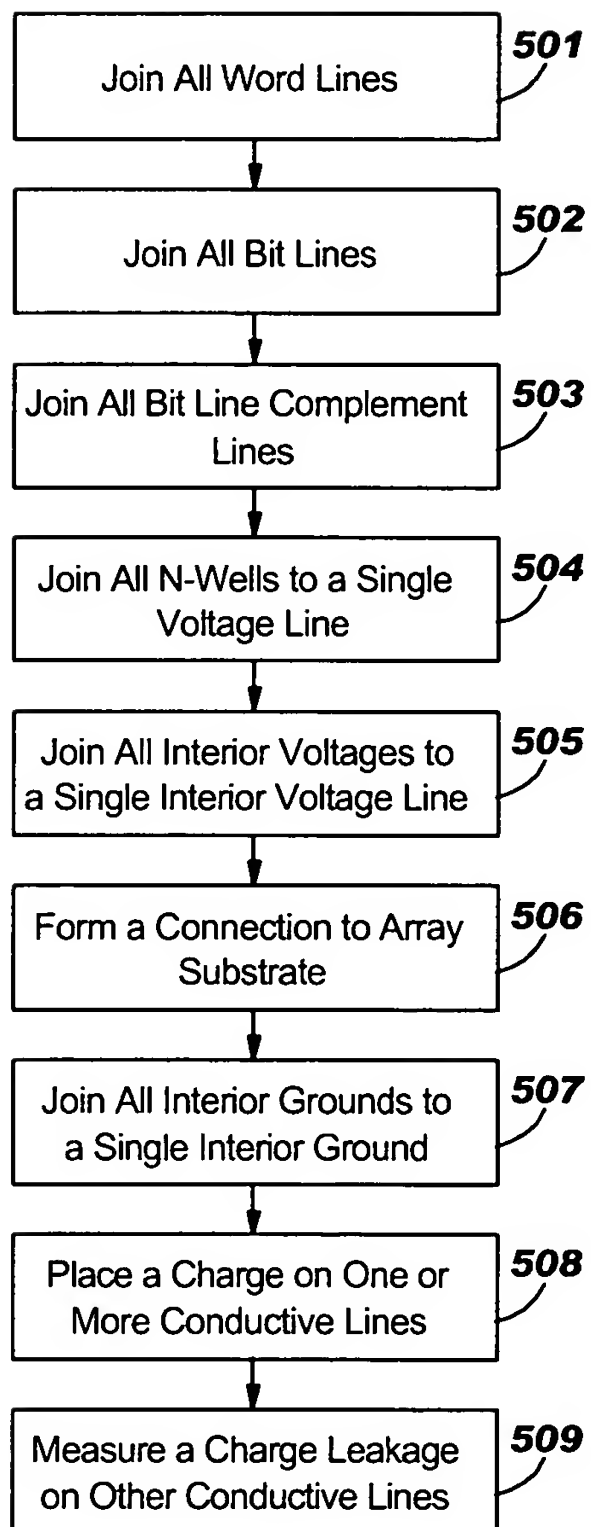
FIG. 4





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FIG. 5



CERTIFICATE OF MAILING BY FIRST CLASS MAIL (37 CFR 1.8)

Applicant(s): Breitwisch et al.

Docket No.

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Application No.

10/064,302

Filing Date

July 1, 2002

Examiner

Auduong, Gene Nghia

Customer No.

29154

Group Art Unit

2818

Invention: METHOD AND DESIGN FOR MEASURING SRAM ARRAY LEAKAGE MACRO (ALM)

I hereby certify that this Certificate of Correction*(Identify type of correspondence)*

is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to "Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450" [37 CFR 1.8(a)] on

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